



Welcome to [E-XFL.COM](https://www.e-xfl.com)

### Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

|                                |   |
|--------------------------------|---|
| Product Status                 | Obsolete  |
| Number of LABs/CLBs            | 1152  |
| Number of Logic Elements/Cells | 11520   |
| Total RAM Bits                 | 147456  |
| Number of I/O                  | 152   |
| Number of Gates                | 728000  |
| Voltage - Supply               | 1.71V ~ 1.89V   |
| Mounting Type                  | Surface Mount   |
| Operating Temperature          | 0°C ~ 85°C (TJ)   |
| Package / Case                 | 240-BFQFP   |
| Supplier Device Package        | 240-PQFP (32x32)  |
| Purchase URL                   | <a href="https://www.e-xfl.com/product-detail/intel/ep20k300eqc240-1">https://www.e-xfl.com/product-detail/intel/ep20k300eqc240-1</a> |

**Table 2. Additional APEX 20K Device Features** *Note (1)*

| Feature               | EP20K300E | EP20K400  | EP20K400E | EP20K600E | EP20K1000E | EP20K1500E |
|-----------------------|-----------|-----------|-----------|-----------|------------|------------|
| Maximum system gates  | 728,000   | 1,052,000 | 1,052,000 | 1,537,000 | 1,772,000  | 2,392,000  |
| Typical gates         | 300,000   | 400,000   | 400,000   | 600,000   | 1,000,000  | 1,500,000  |
| LEs                   | 11,520    | 16,640    | 16,640    | 24,320    | 38,400     | 51,840     |
| ESBs                  | 72        | 104       | 104       | 152       | 160        | 216        |
| Maximum RAM bits      | 147,456   | 212,992   | 212,992   | 311,296   | 327,680    | 442,368    |
| Maximum macrocells    | 1,152     | 1,664     | 1,664     | 2,432     | 2,560      | 3,456      |
| Maximum user I/O pins | 408       | 502       | 488       | 588       | 708        | 808        |

*Note to Tables 1 and 2:*

- (1) The embedded IEEE Std. 1149.1 Joint Test Action Group (JTAG) boundary-scan circuitry contributes up to 57,000 additional gates.

## Additional Features

- Designed for low-power operation
  - 1.8-V and 2.5-V supply voltage (see Table 3)
  - MultiVolt™ I/O interface support to interface with 1.8-V, 2.5-V, 3.3-V, and 5.0-V devices (see Table 3)
  - ESB offering programmable power-saving mode

**Table 3. APEX 20K Supply Voltages**

| Feature   | Device                           |  |
|---|----------------------------------|--|
|   | EP20K100<br>EP20K200<br>EP20K400 | EP20K30E<br>EP20K60E<br>EP20K100E<br>EP20K160E<br>EP20K200E<br>EP20K300E<br>EP20K400E<br>EP20K600E<br>EP20K1000E<br>EP20K1500E |
| Internal supply voltage ( $V_{CCINT}$ )               | 2.5 V                            | 1.8 V  |
| MultiVolt I/O interface voltage levels ( $V_{CCIO}$ ) | 2.5 V, 3.3 V, 5.0 V              | 1.8 V, 2.5 V, 3.3 V, 5.0 V (1)   |

*Note to Table 3:*

- (1) APEX 20KE devices can be 5.0-V tolerant by using an external resistor.

Windows-based PCs, Sun SPARCstations, and HP 9000 Series 700/800 workstations

- Altera MegaCore® functions and Altera Megafunction Partners Program (AMPP<sup>SM</sup>) megafunctions
- NativeLink™ integration with popular synthesis, simulation, and timing analysis tools
- Quartus II SignalTap® embedded logic analyzer simplifies in-system design evaluation by giving access to internal nodes during device operation
- Supports popular revision-control software packages including PVCS, Revision Control System (RCS), and Source Code Control System (SCCS )

**Table 4. APEX 20K QFP, BGA & PGA Package Options & I/O Count**    *Notes (1), (2)*

| Device     | 144-Pin<br>TQFP | 208-Pin<br>PQFP<br>RQFP | 240-Pin<br>PQFP<br>RQFP | 356-Pin BGA | 652-Pin BGA | 655-Pin PGA |
|------------|-----------------|-------------------------|-------------------------|-------------|-------------|-------------|
| EP20K30E   | 92              | 125                     |                         |             |             |             |
| EP20K60E   | 92              | 148                     | 151                     | 196         |             |             |
| EP20K100   | 101             | 159                     | 189                     | 252         |             |             |
| EP20K100E  | 92              | 151                     | 183                     | 246         |             |             |
| EP20K160E  | 88              | 143                     | 175                     | 271         |             |             |
| EP20K200   |                 | 144                     | 174                     | 277         |             |             |
| EP20K200E  |                 | 136                     | 168                     | 271         | 376         |             |
| EP20K300E  |                 |                         | 152                     |             | 408         |             |
| EP20K400   |                 |                         |                         |             | 502         | 502         |
| EP20K400E  |                 |                         |                         |             | 488         |             |
| EP20K600E  |                 |                         |                         |             | 488         |             |
| EP20K1000E |                 |                         |                         |             | 488         |             |
| EP20K1500E |                 |                         |                         |             | 488         |             |

**Table 5. APEX 20K FineLine BGA Package Options & I/O Count** *Notes (1), (2)*

| Device     | 144 Pin | 324 Pin | 484 Pin | 672 Pin | 1,020 Pin |
|------------|---------|---------|---------|---------|-----------|
| EP20K30E   | 93      | 128     |         |         |           |
| EP20K60E   | 93      | 196     |         |         |           |
| EP20K100   |         | 252     |         |         |           |
| EP20K100E  | 93      | 246     |         |         |           |
| EP20K160E  |         |         | 316     |         |           |
| EP20K200   |         |         | 382     |         |           |
| EP20K200E  |         |         | 376     | 376     |           |
| EP20K300E  |         |         |         | 408     |           |
| EP20K400   |         |         |         | 502 (3) |           |
| EP20K400E  |         |         |         | 488 (3) |           |
| EP20K600E  |         |         |         | 508 (3) | 588       |
| EP20K1000E |         |         |         | 508 (3) | 708       |
| EP20K1500E |         |         |         |         | 808       |

**Notes to Tables 4 and 5:**

- (1) I/O counts include dedicated input and clock pins.
- (2) APEX 20K device package types include thin quad flat pack (TQFP), plastic quad flat pack (PQFP), power quad flat pack (RQFP), 1.27-mm pitch ball-grid array (BGA), 1.00-mm pitch FineLine BGA, and pin-grid array (PGA) packages.
- (3) This device uses a thermally enhanced package, which is taller than the regular package. Consult the *Altera Device Package Information Data Sheet* for detailed package size information.

**Table 6. APEX 20K QFP, BGA & PGA Package Sizes**

| Feature                  | 144-Pin TQFP | 208-Pin QFP | 240-Pin QFP | 356-Pin BGA | 652-Pin BGA | 655-Pin PGA |
|--------------------------|--------------|-------------|-------------|-------------|-------------|-------------|
| Pitch (mm)               | 0.50         | 0.50        | 0.50        | 1.27        | 1.27        | —           |
| Area (mm <sup>2</sup> )  | 484          | 924         | 1,218       | 1,225       | 2,025       | 3,906       |
| Length × Width (mm × mm) | 22 × 22      | 30.4 × 30.4 | 34.9 × 34.9 | 35 × 35     | 45 × 45     | 62.5 × 62.5 |

**Table 7. APEX 20K FineLine BGA Package Sizes**

| Feature                  | 144 Pin | 324 Pin | 484 Pin | 672 Pin | 1,020 Pin |
|--------------------------|---------|---------|---------|---------|-----------|
| Pitch (mm)               | 1.00    | 1.00    | 1.00    | 1.00    | 1.00      |
| Area (mm <sup>2</sup> )  | 169     | 361     | 529     | 729     | 1,089     |
| Length × Width (mm × mm) | 13 × 13 | 19 × 19 | 23 × 23 | 27 × 27 | 33 × 33   |

**Table 8. Comparison of APEX 20K & APEX 20KE Features**

| Feature                        | APEX 20K Devices   | APEX 20KE Devices  |
|--------------------------------|--|--|
| MultiCore system integration   | Full support   | Full support   |
| SignalTap logic analysis       | Full support   | Full support   |
| 32/64-Bit, 33-MHz PCI          | Full compliance in -1, -2 speed grades   | Full compliance in -1, -2 speed grades   |
| 32/64-Bit, 66-MHz PCI          | -  | Full compliance in -1 speed grade  |
| MultiVolt I/O                  | 2.5-V or 3.3-V $V_{CCIO}$<br>$V_{CCIO}$ selected for device<br>Certain devices are 5.0-V tolerant  | 1.8-V, 2.5-V, or 3.3-V $V_{CCIO}$<br>$V_{CCIO}$ selected block-by-block<br>5.0-V tolerant with use of external resistor  |
| ClockLock support              | Clock delay reduction<br>2× and 4× clock multiplication  | Clock delay reduction<br>$m/(n \times v)$ or $m/(n \times k)$ clock multiplication<br>Drive ClockLock output off-chip<br>External clock feedback<br>ClockShift<br>LVDS support<br>Up to four PLLs<br>ClockShift, clock phase adjustment  |
| Dedicated clock and input pins | Six  | Eight  |
| I/O standard support           | 2.5-V, 3.3-V, 5.0-V I/O<br>3.3-V PCI<br>Low-voltage complementary metal-oxide semiconductor (LVCMOS)<br>Low-voltage transistor-to-transistor logic (LVTTL) | 1.8-V, 2.5-V, 3.3-V, 5.0-V I/O<br>2.5-V I/O<br>3.3-V PCI and PCI-X<br>3.3-V Advanced Graphics Port (AGP)<br>Center tap terminated (CTT)<br>GTL+<br>LVCMOS<br>LVTTL<br>True-LVDS and LVPECL data pins (in EP20K300E and larger devices)<br>LVDS and LVPECL signaling (in all BGA and FineLine BGA devices)<br>LVDS and LVPECL data pins up to 156 Mbps (in -1 speed grade devices)<br>HSTL Class I<br>PCI-X<br>SSTL-2 Class I and II<br>SSTL-3 Class I and II |
| Memory support                 | Dual-port RAM<br>FIFO<br>RAM<br>ROM  | CAM<br>Dual-port RAM<br>FIFO<br>RAM<br>ROM   |

## Functional Description

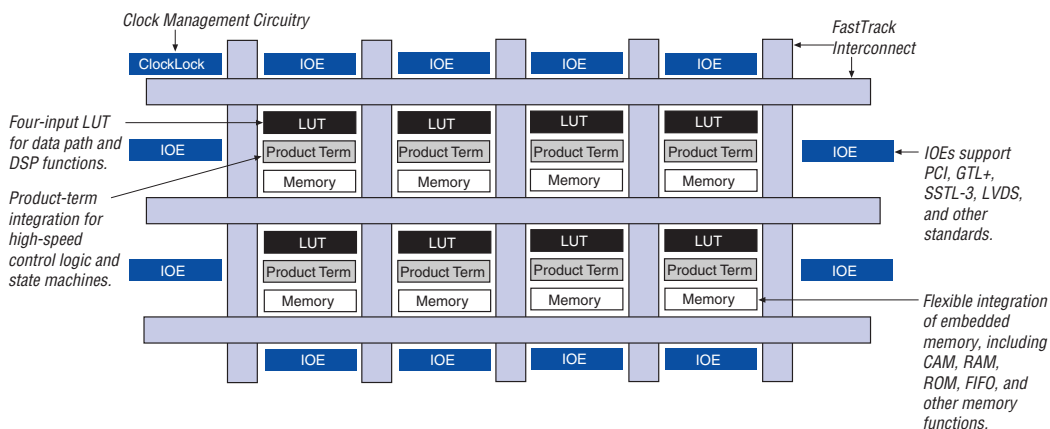
APEX 20K devices incorporate LUT-based logic, product-term-based logic, and memory into one device. Signal interconnections within APEX 20K devices (as well as to and from device pins) are provided by the FastTrack<sup>®</sup> Interconnect—a series of fast, continuous row and column channels that run the entire length and width of the device.

Each I/O pin is fed by an I/O element (IOE) located at the end of each row and column of the FastTrack Interconnect. Each IOE contains a bidirectional I/O buffer and a register that can be used as either an input or output register to feed input, output, or bidirectional signals. When used with a dedicated clock pin, these registers provide exceptional performance. IOEs provide a variety of features, such as 3.3-V, 64-bit, 66-MHz PCI compliance; JTAG BST support; slew-rate control; and tri-state buffers. APEX 20KE devices offer enhanced I/O support, including support for 1.8-V I/O, 2.5-V I/O, LVCMOS, LVTTL, LVPECL, 3.3-V PCI, PCI-X, LVDS, GTL+, SSTL-2, SSTL-3, HSTL, CTT, and 3.3-V AGP I/O standards.

The ESB can implement a variety of memory functions, including CAM, RAM, dual-port RAM, ROM, and FIFO functions. Embedding the memory directly into the die improves performance and reduces die area compared to distributed-RAM implementations. Moreover, the abundance of cascadable ESBs ensures that the APEX 20K device can implement multiple wide memory blocks for high-density designs. The ESB's high speed ensures it can implement small memory blocks without any speed penalty. The abundance of ESBs ensures that designers can create as many different-sized memory blocks as the system requires.

Figure 1 shows an overview of the APEX 20K device.

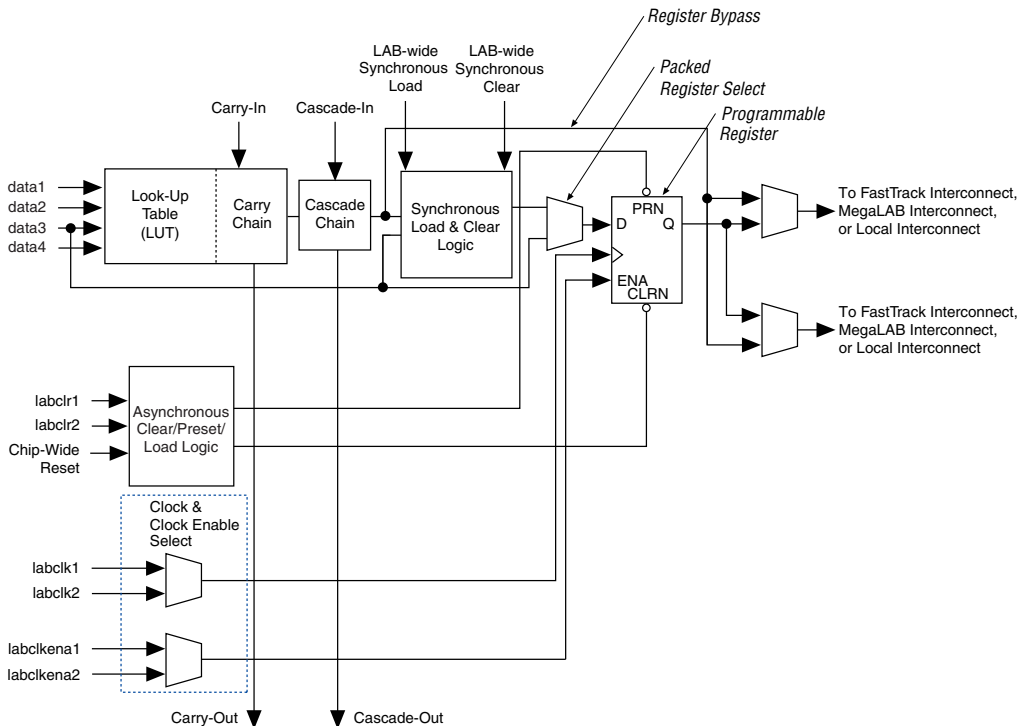
**Figure 1. APEX 20K Device Block Diagram**



## Logic Element

The LE, the smallest unit of logic in the APEX 20K architecture, is compact and provides efficient logic usage. Each LE contains a four-input LUT, which is a function generator that can quickly implement any function of four variables. In addition, each LE contains a programmable register and carry and cascade chains. Each LE drives the local interconnect, MegaLAB interconnect, and FastTrack Interconnect routing structures. See [Figure 5](#).

**Figure 5. APEX 20K Logic Element**



Each LE's programmable register can be configured for D, T, JK, or SR operation. The register's clock and clear control signals can be driven by global signals, general-purpose I/O pins, or any internal logic. For combinatorial functions, the register is bypassed and the output of the LUT drives the outputs of the LE.

**Table 9. APEX 20K Routing Scheme**

| Source                        | Destination |                |    |     |                    |                      |                            |                               |                      |
|-------------------------------|-------------|----------------|----|-----|--------------------|----------------------|----------------------------|-------------------------------|----------------------|
|                               | Row I/O Pin | Column I/O Pin | LE | ESB | Local Interconnect | MegaLAB Interconnect | Row FastTrack Interconnect | Column FastTrack Interconnect | FastRow Interconnect |
| Row I/O Pin                   |             |                |    |     | ✓                  | ✓                    | ✓                          | ✓                             |                      |
| Column I/O Pin                |             |                |    |     |                    |                      |                            | ✓                             | ✓<br>(1)             |
| LE                            |             |                |    |     | ✓                  | ✓                    | ✓                          | ✓                             |                      |
| ESB                           |             |                |    |     | ✓                  | ✓                    | ✓                          | ✓                             |                      |
| Local Interconnect            | ✓           | ✓              | ✓  | ✓   |                    |                      |                            |                               |                      |
| MegaLAB Interconnect          |             |                |    |     | ✓                  |                      |                            |                               |                      |
| Row FastTrack Interconnect    |             |                |    |     |                    | ✓                    |                            | ✓                             |                      |
| Column FastTrack Interconnect |             |                |    |     |                    | ✓                    | ✓                          |                               |                      |
| FastRow Interconnect          |             |                |    |     | ✓<br>(1)           |                      |                            |                               |                      |

**Note to Table 9:**

(1) This connection is supported in APEX 20KE devices only.

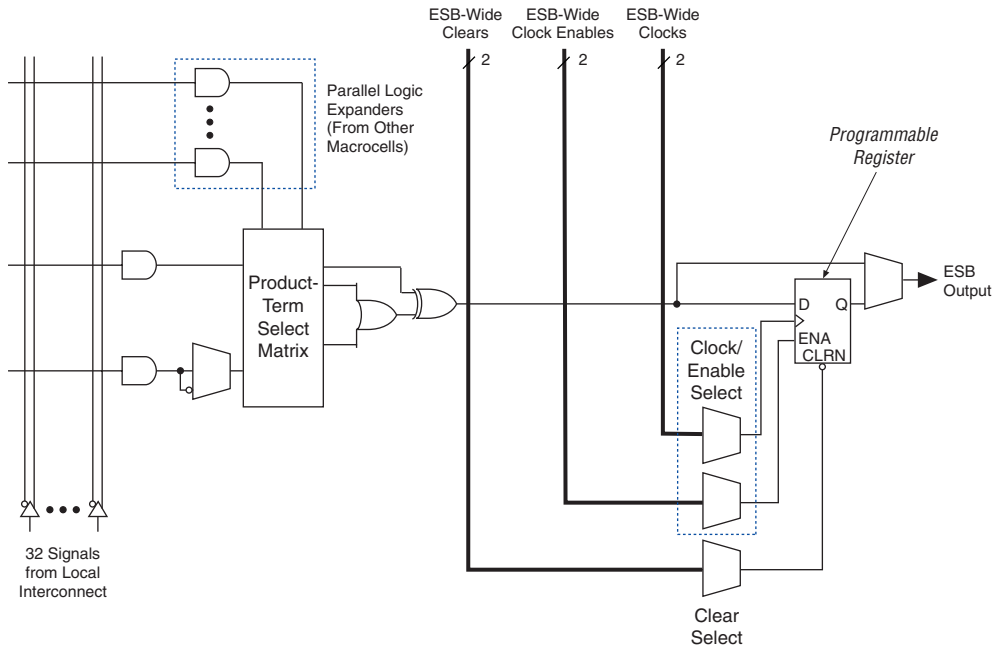
## Product-Term Logic

The product-term portion of the MultiCore architecture is implemented with the ESB. The ESB can be configured to act as a block of macrocells on an ESB-by-ESB basis. Each ESB is fed by 32 inputs from the adjacent local interconnect; therefore, it can be driven by the MegaLAB interconnect or the adjacent LAB. Also, nine ESB macrocells feed back into the ESB through the local interconnect for higher performance. Dedicated clock pins, global signals, and additional inputs from the local interconnect drive the ESB control signals.

In product-term mode, each ESB contains 16 macrocells. Each macrocell consists of two product terms and a programmable register. Figure 13 shows the ESB in product-term mode.



**Figure 14. APEX 20K Macrocell**

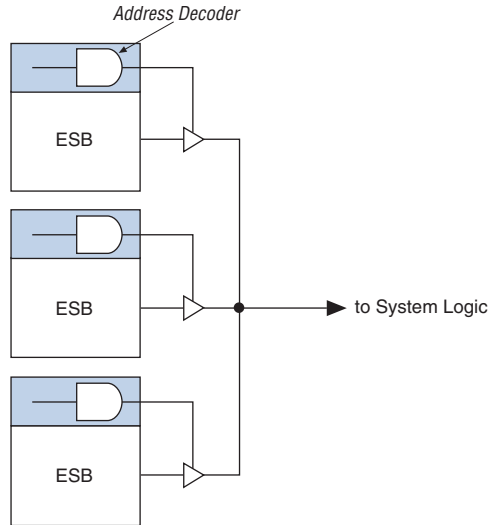


For registered functions, each macrocell register can be programmed individually to implement D, T, JK, or SR operation with programmable clock control. The register can be bypassed for combinatorial operation. During design entry, the designer specifies the desired register type; the Quartus II software then selects the most efficient register operation for each registered function to optimize resource utilization. The Quartus II software or other synthesis tools can also select the most efficient register operation automatically when synthesizing HDL designs.

Each programmable register can be clocked by one of two ESB-wide clocks. The ESB-wide clocks can be generated from device dedicated clock pins, global signals, or local interconnect. Each clock also has an associated clock enable, generated from the local interconnect. The clock and clock enable signals are related for a particular ESB; any macrocell using a clock also uses the associated clock enable.

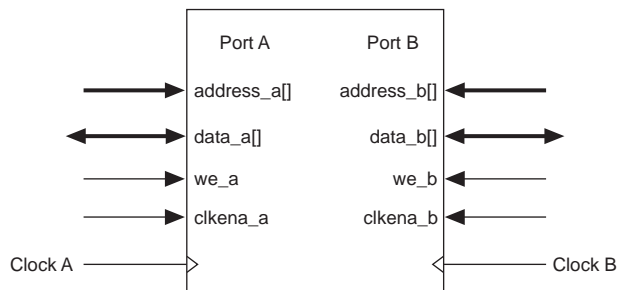
If both the rising and falling edges of a clock are used in an ESB, both ESB-wide clock signals are used.

**Figure 18. Deep Memory Block Implemented with Multiple ESBs**



The ESB implements two forms of dual-port memory: read/write clock mode and input/output clock mode. The ESB can also be used for bidirectional, dual-port memory applications in which two ports read or write simultaneously. To implement this type of dual-port memory, two or four ESBs are used to support two simultaneous reads or writes. This functionality is shown in [Figure 19](#).

**Figure 19. APEX 20K ESB Implementing Dual-Port RAM**



## Implementing Logic in ROM

In addition to implementing logic with product terms, the ESB can implement logic functions when it is programmed with a read-only pattern during configuration, creating a large LUT. With LUTs, combinatorial functions are implemented by looking up the results, rather than by computing them. This implementation of combinatorial functions can be faster than using algorithms implemented in general logic, a performance advantage that is further enhanced by the fast access times of ESBs. The large capacity of ESBs enables designers to implement complex functions in one logic level without the routing delays associated with linked LEs or distributed RAM blocks. Parameterized functions such as LPM functions can take advantage of the ESB automatically. Further, the Quartus II software can implement portions of a design with ESBs where appropriate.

## Programmable Speed/Power Control

APEX 20K ESBs offer a high-speed mode that supports very fast operation on an ESB-by-ESB basis. When high speed is not required, this feature can be turned off to reduce the ESB's power dissipation by up to 50%. ESBs that run at low power incur a nominal timing delay adder. This Turbo Bit™ option is available for ESBs that implement product-term logic or memory functions. An ESB that is not used will be powered down so that it does not consume DC current.

Designers can program each ESB in the APEX 20K device for either high-speed or low-power operation. As a result, speed-critical paths in the design can run at high speed, while the remaining paths operate at reduced power.

## I/O Structure

The APEX 20K IOE contains a bidirectional I/O buffer and a register that can be used either as an input register for external data requiring fast setup times, or as an output register for data requiring fast clock-to-output performance. IOEs can be used as input, output, or bidirectional pins. For fast bidirectional I/O timing, LE registers using local routing can improve setup times and OE timing. The Quartus II software Compiler uses the programmable inversion option to invert signals from the row and column interconnect automatically where appropriate. Because the APEX 20K IOE offers one output enable per pin, the Quartus II software Compiler can emulate open-drain operation efficiently.

The APEX 20K IOE includes programmable delays that can be activated to ensure zero hold times, minimum clock-to-output times, input IOE register-to-core register transfers, or core-to-output IOE register transfers. A path in which a pin directly drives a register may require the delay to ensure zero hold time, whereas a path in which a pin drives a register through combinatorial logic may not require the delay.

Table 10 describes the APEX 20K programmable delays and their logic options in the Quartus II software.

| <b>Table 10. APEX 20K Programmable Delay Chains</b> |   |
|---|---|
| <b>Programmable Delays</b>                          | <b>Quartus II Logic Option</b>          |
| Input pin to core delay                             | Decrease input delay to internal cells  |
| Input pin to input register delay                   | Decrease input delay to input register  |
| Core to output register delay                       | Decrease input delay to output register |
| Output register $t_{CO}$ delay                      | Increase delay to output pin            |

The Quartus II software compiler can program these delays automatically to minimize setup time while providing a zero hold time. Figure 25 shows how fast bidirectional I/Os are implemented in APEX 20K devices.

The register in the APEX 20K IOE can be programmed to power-up high or low after configuration is complete. If it is programmed to power-up low, an asynchronous clear can control the register. If it is programmed to power-up high, the register cannot be asynchronously cleared or preset. This feature is useful for cases where the APEX 20K device controls an active-low input or another device; it prevents inadvertent activation of the input upon power-up.

## Advanced I/O Standard Support

APEX 20KE IOEs support the following I/O standards: LVTTTL, LVCMOS, 1.8-V I/O, 2.5-V I/O, 3.3-V PCI, PCI-X, 3.3-V AGP, LVDS, LVPECL, GTL+, CTT, HSTL Class I, SSTL-3 Class I and II, and SSTL-2 Class I and II.



For more information on I/O standards supported by APEX 20KE devices, see *Application Note 117 (Using Selectable I/O Standards in Altera Devices)*.

The APEX 20KE device contains eight I/O banks. In QFP packages, the banks are linked to form four I/O banks. The I/O banks directly support all standards except LVDS and LVPECL. All I/O banks can support LVDS and LVPECL with the addition of external resistors. In addition, one block within a bank contains circuitry to support high-speed True-LVDS and LVPECL inputs, and another block within a particular bank supports high-speed True-LVDS and LVPECL outputs. The LVDS blocks support all of the I/O standards. Each I/O bank has its own VCCIO pins. A single device can support 1.8-V, 2.5-V, and 3.3-V interfaces; each bank can support a different standard independently. Each bank can also use a separate  $V_{REF}$  level so that each bank can support any of the terminated standards (such as SSTL-3) independently. Within a bank, any one of the terminated standards can be supported. EP20K300E and larger APEX 20KE devices support the LVDS interface for data pins (smaller devices support LVDS clock pins, but not data pins). All EP20K300E and larger devices support the LVDS interface for data pins up to 155 Mbit per channel; EP20K400E devices and larger with an X-suffix on the ordering code add a serializer/deserializer circuit and PLL for higher-speed support.

Each bank can support multiple standards with the same VCCIO for output pins. Each bank can support one voltage-referenced I/O standard, but it can support multiple I/O standards with the same VCCIO voltage level. For example, when VCCIO is 3.3 V, a bank can support LVTTTL, LVCMOS, 3.3-V PCI, and SSTL-3 for inputs and outputs.

When the LVDS banks are not used as LVDS I/O banks, they support all of the other I/O standards. [Figure 29](#) shows the arrangement of the APEX 20KE I/O banks.

For designs that require both a multiplied and non-multiplied clock, the clock trace on the board can be connected to CLK2p. Table 14 shows the combinations supported by the ClockLock and ClockBoost circuitry. The CLK2p pin can feed both the ClockLock and ClockBoost circuitry in the APEX 20K device. However, when both circuits are used, the other clock pin (CLK1p) cannot be used.

**Table 14. Multiplication Factor Combinations**

| Clock 1    | Clock 2 |
|------------|---------|
| ×1         | ×1      |
| ×1, ×2     | ×2      |
| ×1, ×2, ×4 | ×4      |

## APEX 20KE ClockLock Feature

APEX 20KE devices include an enhanced ClockLock feature set. These devices include up to four PLLs, which can be used independently. Two PLLs are designed for either general-purpose use or LVDS use (on devices that support LVDS I/O pins). The remaining two PLLs are designed for general-purpose use. The EP20K200E and smaller devices have two PLLs; the EP20K300E and larger devices have four PLLs.

The following sections describe some of the features offered by the APEX 20KE PLLs.

### *External PLL Feedback*

The ClockLock circuit's output can be driven off-chip to clock other devices in the system; further, the feedback loop of the PLL can be routed off-chip. This feature allows the designer to exercise fine control over the I/O interface between the APEX 20KE device and another high-speed device, such as SDRAM.

### *Clock Multiplication*

The APEX 20KE ClockBoost circuit can multiply or divide clocks by a programmable number. The clock can be multiplied by  $m/(n \times k)$  or  $m/(n \times v)$ , where  $m$  and  $k$  range from 2 to 160, and  $n$  and  $v$  range from 1 to 16. Clock multiplication and division can be used for time-domain multiplexing and other functions, which can reduce design LE requirements.

The APEX 20K device instruction register length is 10 bits. The APEX 20K device USERCODE register length is 32 bits. [Tables 20 and 21](#) show the boundary-scan register length and device IDCODE information for APEX 20K devices.

**Table 20. APEX 20K Boundary-Scan Register Length**

| Device     | Boundary-Scan Register Length |
|------------|-------------------------------|
| EP20K30E   | 420                           |
| EP20K60E   | 624                           |
| EP20K100   | 786                           |
| EP20K100E  | 774                           |
| EP20K160E  | 984                           |
| EP20K200   | 1,176                         |
| EP20K200E  | 1,164                         |
| EP20K300E  | 1,266                         |
| EP20K400   | 1,536                         |
| EP20K400E  | 1,506                         |
| EP20K600E  | 1,806                         |
| EP20K1000E | 2,190                         |
| EP20K1500E | 1 <a href="#">(1)</a>         |

**Note to [Table 20](#):**

- (1) This device does not support JTAG boundary scan testing.

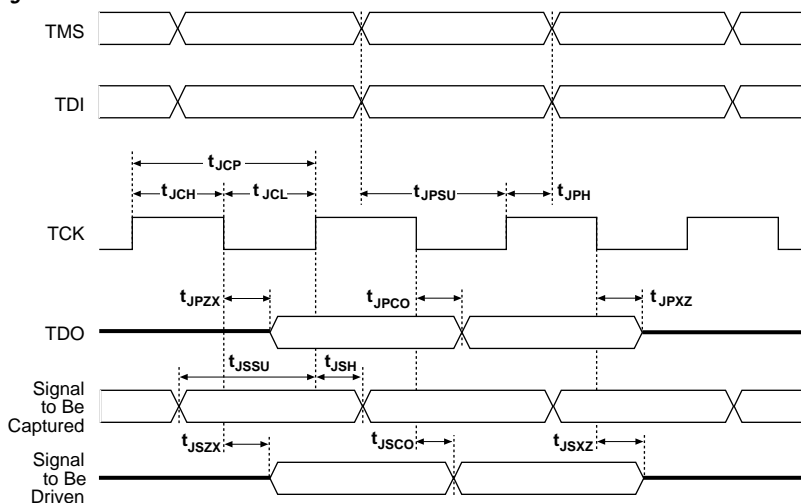
**Table 21. 32-Bit APEX 20K Device IDCODE**

| Device     | IDCODE (32 Bits) <sup>(1)</sup> |                       |                                 |                          |
|------------|---------------------------------|-----------------------|---------------------------------|--------------------------|
|            | Version (4 Bits)                | Part Number (16 Bits) | Manufacturer Identity (11 Bits) | 1 (1 Bit) <sup>(2)</sup> |
| EP20K30E   | 0000                            | 1000 0000 0011 0000   | 000 0110 1110                   | 1                        |
| EP20K60E   | 0000                            | 1000 0000 0110 0000   | 000 0110 1110                   | 1                        |
| EP20K100   | 0000                            | 0000 0100 0001 0110   | 000 0110 1110                   | 1                        |
| EP20K100E  | 0000                            | 1000 0001 0000 0000   | 000 0110 1110                   | 1                        |
| EP20K160E  | 0000                            | 1000 0001 0110 0000   | 000 0110 1110                   | 1                        |
| EP20K200   | 0000                            | 0000 1000 0011 0010   | 000 0110 1110                   | 1                        |
| EP20K200E  | 0000                            | 1000 0010 0000 0000   | 000 0110 1110                   | 1                        |
| EP20K300E  | 0000                            | 1000 0011 0000 0000   | 000 0110 1110                   | 1                        |
| EP20K400   | 0000                            | 0001 0110 0110 0100   | 000 0110 1110                   | 1                        |
| EP20K400E  | 0000                            | 1000 0100 0000 0000   | 000 0110 1110                   | 1                        |
| EP20K600E  | 0000                            | 1000 0110 0000 0000   | 000 0110 1110                   | 1                        |
| EP20K1000E | 0000                            | 1001 0000 0000 0000   | 000 0110 1110                   | 1                        |

**Notes to Table 21:**

- (1) The most significant bit (MSB) is on the left.  
 (2) The IDCODE's least significant bit (LSB) is always 1.

Figure 31 shows the timing requirements for the JTAG signals.

**Figure 31. APEX 20K JTAG Waveforms**



Note to [Tables 32 and 33](#):

(1) These timing parameters are sample-tested only.

[Tables 34 through 37](#) show APEX 20KE LE, ESB, routing, and functional timing microparameters for the  $f_{MAX}$  timing model.

**Table 34. APEX 20KE LE Timing Microparameters**

| Symbol    | Parameter                           |
|-----------|-------------------------------------|
| $t_{SU}$  | LE register setup time before clock |
| $t_H$     | LE register hold time after clock   |
| $t_{CO}$  | LE register clock-to-output delay   |
| $t_{LUT}$ | LUT delay for data-in to data-out   |

**Table 35. APEX 20KE ESB Timing Microparameters**

| Symbol           | Parameter  |
|------------------|--|
| $t_{ESBARC}$     | ESB Asynchronous read cycle time                                     |
| $t_{ESBSRC}$     | ESB Synchronous read cycle time                                      |
| $t_{ESBAWC}$     | ESB Asynchronous write cycle time                                    |
| $t_{ESBSWC}$     | ESB Synchronous write cycle time                                     |
| $t_{ESBWASU}$    | ESB write address setup time with respect to WE                      |
| $t_{ESBWAH}$     | ESB write address hold time with respect to WE                       |
| $t_{ESBWDSU}$    | ESB data setup time with respect to WE                               |
| $t_{ESBWDH}$     | ESB data hold time with respect to WE                                |
| $t_{ESBRASU}$    | ESB read address setup time with respect to RE                       |
| $t_{ESBRAH}$     | ESB read address hold time with respect to RE                        |
| $t_{ESBWESU}$    | ESB WE setup time before clock when using input register             |
| $t_{ESBWEH}$     | ESB WE hold time after clock when using input register               |
| $t_{ESBDATASU}$  | ESB data setup time before clock when using input register           |
| $t_{ESBDATAH}$   | ESB data hold time after clock when using input register             |
| $t_{ESBWADDRSU}$ | ESB write address setup time before clock when using input registers |
| $t_{ESBRADDRSU}$ | ESB read address setup time before clock when using input registers  |
| $t_{ESBDATACO1}$ | ESB clock-to-output delay when using output registers                |
| $t_{ESBDATACO2}$ | ESB clock-to-output delay without output registers                   |
| $t_{ESBDD}$      | ESB data-in to data-out delay for RAM mode                           |
| $t_{PD}$         | ESB Macrocell input to non-registered output                         |
| $t_{PTERMSU}$    | ESB Macrocell register setup time before clock                       |
| $t_{PTERMCO}$    | ESB Macrocell register clock-to-output delay                         |

**Table 36. APEX 20KE Routing Timing Microparameters** *Note (1)*

| Symbol      | Parameter  |
|-------------|--|
| $t_{F1-4}$  | Fanout delay using Local Interconnect              |
| $t_{F5-20}$ | Fanout delay estimate using MegaLab Interconnect   |
| $t_{F20+}$  | Fanout delay estimate using FastTrack Interconnect |

*Note to Table 36:*

- (1) These parameters are worst-case values for typical applications. Post-compilation timing simulation and timing analysis are required to determine actual worst-case performance.

**Table 37. APEX 20KE Functional Timing Microparameters**

| Symbol | Parameter                              |
|--------|--|
| TCH    | Minimum clock high time from clock pin |
| TCL    | Minimum clock low time from clock pin  |
| TCLRP  | LE clear Pulse Width                   |
| TPREP  | LE preset pulse width                  |
| TESBCH | Clock high time for ESB                |
| TESBCL | Clock low time for ESB                 |
| TESBWP | Write pulse width                      |
| TESBRP | Read pulse width                       |

Tables 38 and 39 describe the APEX 20KE external timing parameters.

**Table 38. APEX 20KE External Timing Parameters** *Note (1)*

| Symbol         | Clock Parameter  | Conditions |
|----------------|--|------------|
| $t_{INSU}$     | Setup time with global clock at IOE input register             |            |
| $t_{INH}$      | Hold time with global clock at IOE input register              |            |
| $t_{OUTCO}$    | Clock-to-output delay with global clock at IOE output register | C1 = 10 pF |
| $t_{INSUPLL}$  | Setup time with PLL clock at IOE input register                |            |
| $t_{INHPLL}$   | Hold time with PLL clock at IOE input register                 |            |
| $t_{OUTCOPLL}$ | Clock-to-output delay with PLL clock at IOE output register    | C1 = 10 pF |

**Table 108. EP20K1500E External Bidirectional Timing Parameters**

| Symbol                     | -1 Speed Grade |      | -2 Speed Grade |      | -3 Speed Grade |      | Unit |
|----------------------------|----------------|------|----------------|------|----------------|------|------|
|                            | Min            | Max  | Min            | Max  | Min            | Max  |      |
| $t_{\text{INSUBIDIR}}$     | 3.47           |      | 3.68           |      | 3.99           |      | ns   |
| $t_{\text{INHBIDIR}}$      | 0.00           |      | 0.00           |      | 0.00           |      | ns   |
| $t_{\text{OUTCOBIDIR}}$    | 2.00           | 6.18 | 2.00           | 6.81 | 2.00           | 7.36 | ns   |
| $t_{\text{XZBIDIR}}$       |                | 6.91 |                | 7.62 |                | 8.38 | ns   |
| $t_{\text{ZXBIDIR}}$       |                | 6.91 |                | 7.62 |                | 8.38 | ns   |
| $t_{\text{INSUBIDIRPLL}}$  | 3.05           |      | 3.26           |      |                |      | ns   |
| $t_{\text{INHBIDIRPLL}}$   | 0.00           |      | 0.00           |      |                |      | ns   |
| $t_{\text{OUTCOBIDIRPLL}}$ | 0.50           | 2.67 | 0.50           | 2.99 |                |      | ns   |
| $t_{\text{XZBIDIRPLL}}$    |                | 3.41 |                | 3.80 |                |      | ns   |
| $t_{\text{ZXBIDIRPLL}}$    |                | 3.41 |                | 3.80 |                |      | ns   |

Tables 109 and 110 show selectable I/O standard input and output delays for APEX 20KE devices. If you select an I/O standard input or output delay other than LVCMOS, add or subtract the selected speed grade to or from the LVCMOS value.

**Table 109. Selectable I/O Standard Input Delays**

| Symbol          | -1 Speed Grade |       | -2 Speed Grade |       | -3 Speed Grade |       | Unit |
|-----------------|----------------|-------|----------------|-------|----------------|-------|------|
|                 | Min            | Max   | Min            | Max   | Min            | Max   | Min  |
| LVCMOS          |                | 0.00  |                | 0.00  |                | 0.00  | ns   |
| LVTTL           |                | 0.00  |                | 0.00  |                | 0.00  | ns   |
| 2.5 V           |                | 0.00  |                | 0.04  |                | 0.05  | ns   |
| 1.8 V           |                | -0.11 |                | 0.03  |                | 0.04  | ns   |
| PCI             |                | 0.01  |                | 0.09  |                | 0.10  | ns   |
| GTL+            |                | -0.24 |                | -0.23 |                | -0.19 | ns   |
| SSTL-3 Class I  |                | -0.32 |                | -0.21 |                | -0.47 | ns   |
| SSTL-3 Class II |                | -0.08 |                | 0.03  |                | -0.23 | ns   |
| SSTL-2 Class I  |                | -0.17 |                | -0.06 |                | -0.32 | ns   |
| SSTL-2 Class II |                | -0.16 |                | -0.05 |                | -0.31 | ns   |
| LVDS            |                | -0.12 |                | -0.12 |                | -0.12 | ns   |
| CTT             |                | 0.00  |                | 0.00  |                | 0.00  | ns   |
| AGP             |                | 0.00  |                | 0.00  |                | 0.00  | ns   |

SRAM configuration elements allow APEX 20K devices to be reconfigured in-circuit by loading new configuration data into the device. Real-time reconfiguration is performed by forcing the device into command mode with a device pin, loading different configuration data, reinitializing the device, and resuming user-mode operation. In-field upgrades can be performed by distributing new configuration files.

Configuration Schemes

The configuration data for an APEX 20K device can be loaded with one of five configuration schemes (see Table 111), chosen on the basis of the target application. An EPC2 or EPC16 configuration device, intelligent controller, or the JTAG port can be used to control the configuration of an APEX 20K device. When a configuration device is used, the system can configure automatically at system power-up.

Multiple APEX 20K devices can be configured in any of five configuration schemes by connecting the configuration enable (nCE) and configuration enable output (nCEO) pins on each device.

| Table 111. Data Sources for Configuration |  |
|---|--|
| Configuration Scheme                      | Data Source  |
| Configuration device                      | EPC1, EPC2, EPC16 configuration devices  |
| Passive serial (PS)                       | MasterBlaster or ByteBlasterMV download cable or serial data source                      |
| Passive parallel asynchronous (PPA)       | Parallel data source   |
| Passive parallel synchronous (PPS)        | Parallel data source   |
| JTAG                                      | MasterBlaster or ByteBlasterMV download cable or a microprocessor with a Jam or JBC File |



For more information on configuration, see *Application Note 116 (Configuring APEX 20K, FLEX 10K, & FLEX 6000 Devices.)*

Device Pin-Outs

See the Altera web site (<http://www.altera.com>) or the *Altera Digital Library* for pin-out information



101 Innovation Drive  
San Jose, CA 95134  
(408) 544-7000  
<http://www.altera.com>  
**Applications Hotline:**  
(800) 800-EPLD  
**Customer Marketing:**  
(408) 544-7104  
**Literature Services:**  
[lit\\_req@altera.com](mailto:lit_req@altera.com)

Copyright © 2004 Altera Corporation. All rights reserved. Altera, The Programmable Solutions Company, the stylized Altera logo, specific device designations, and all other words and logos that are identified as trademarks and/or service marks are, unless noted otherwise, the trademarks and service marks of Altera Corporation in the U.S. and other countries. All other product or service names are the property of their respective holders. Altera products are protected under numerous U.S. and foreign patents and pending applications, mask work rights, and copyrights. Altera warrants performance of its semiconductor products to current specifications in accordance with Altera's standard warranty, but reserves the right to make changes to any products and services at any time without notice. Altera assumes no responsibility or liability arising out of the application or use of any information, product, or service described herein except as expressly agreed to in writing by Altera Corporation. Altera customers are advised to obtain the latest version of device specifications before relying on any published information and before placing orders for products or services.



I.S. EN ISO 9001